

# Metal Composite Power Inductor (Thin Film)

## **Specification Sheet**



### CIGT160808XMR24MNC (1608 / EIA 0603)

Smart phones, Tablet, Wearable devices, Power converter modules, etc.

Small power inductor for mobile devices Low DCR structure and high efficiency inductor for power circuits. Monolithic structure for high reliability Free of all RoHS-regulated substances Halogen free



Bort po	Part no. Size [inch/mm] Thickness [mm] (max)	Inductance	Inductance tolerance	DC Resistance [mΩ]		Rated DC Current (Isat) [A]		Rated DC Current (Irms) [A]		
Faitho.		[mm] (max)	[uH]	(%)	Max.	Тур.	Max.	Тур.	Max.	Тур.
CIGT160808XMR24MNC	0603/1608	0.8	0.24	±20	24	19	4.1	4.6	4.3	4.9

\* Inductance : Measured with a LCR meter 4991A(Agilent) or equivalent (Test Freq. 1MHz, Level 0.1V)

\* DC Resistance : Measured with a Resistance HI-TESTER 3541(HIOKI) or equivalent

\* Maximum allowable DC current : Value defined when DC current flows and the initial value of inductance has decreased by 30% or

when current flows and temperature has risen to 40°C whichever is smaller. (Reference: ambient temperature is 25°C±10) (Isat) : Allowable current in DC saturation : The DC saturation allowable current value is specified when the decrease of

the initial inductance value at 30% (Reference: ambient temperature is 25°C±10)

(Irms) : Allowable current of temperature rise : The temperature rise allowable current value is specified when temperature of the inductor is raised 40°C by DC current. (Reference: ambient temperature is 25°C±10)

\* Absolute maximum voltage : Rated Voltage 20V.

\* Operating temperature range : -40 to +125°C (Including self-temperature rise)

<u>CIG</u>	Τ	<u>1608</u>	<u>08</u>	<u>XM</u>	<u>R24</u>	M	<u>N</u>	<u>C</u>
(1)	(2)	(3)	(4)	(5)	(6)	(7)	(8)	(9)

(2) Type

(4) Thicknes (08: 0.8mm)

(6) Inductan (R24: 0.24 uH)

(1) Power Inductor

(3) Dimensior (1608: 1.6mm × 0.8mm )

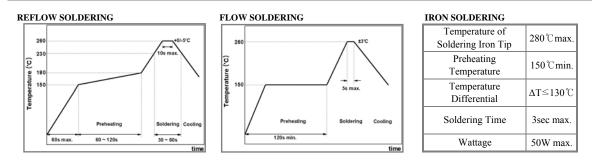
(5) Remark (Characterization Code)

(7) Toleranc (M:±20%)

(8) Internal Code

(9) Packaging (C:paper tape, E:embossed tape)

### RECOMMENDED SOLDERING CONDITION



Packaging Style	Quantity(pcs/reel)		
Card Board Taping	4000 pcs		

# RECOMMENDED LAND PATTERN

(T: Metal Composite Thin Film Type)

				Unit : mm
			TYPE	1608
		c	A	0.8
			В	0.5
		Ļ	С	0.9
⊨ B				

TYPE	Dimension [mm]						
TIFE	L	W	Т	D			
1608	1.6±0.2	0.8±0.2	0.8 max	0.3±0.2			

ltem	Specified Value	Test Condition			
Solderability	More than 90% of terminal electrode should be soldered newly.	After being dipped in flux for $4\pm 1$ seconds, and preheated at $150 \sim 180^{\circ}$ for $2 \sim 3$ min, the specimen shall be immersed in solder at $245\pm 5^{\circ}$ for $4\pm 1$ seconds.			
Resistance to Soldering	No mechanical damage. Remaining terminal Electrode: 75% min. Inductance change to be within ±20% to the initial.	After being dipped in flux for 4±1 seconds, and preheated at $150 \sim 180^{\circ}$ for 2 $\sim$ 3 min, the specimen shall be immersed in solder at 260±5°C for 10 ±0.5 seconds.			
Thermal Shock (Temperature Cycle test)	No mechanical damage Inductance change to be within ±20% to the initial.	Repeat 100 cycles under the following conditions. -40±3 °C for 30 min $\rightarrow$ 85±3 °C for 30 min			
High Temp. Humidity Resistance Test	No mechanical damage Inductance change to be within ±20% to the initial	85±2°C, 85%RH, for 500±12 hours. Measure the test items after leaving at normal temperature and humidity for 24 hours.			
Low Temperature Test	No mechanical damage Inductance change to be within ±20% to the initial.	Solder the sample on PCB. Exposure at -55±2°C for 500±12 hours. Measure the test items after leaving at normal temperature and humidity for 24hours.			
High Temperature Test	No mechanical damage Inductance change to be within ±20% to the initial.	Solder the sample on PCB. Exposure at 125±2 <sup>°</sup> C for 500±12 hours. Measure the test items after leaving at normal temperature and humidity for 24hours.			
High Temp. Humidity Resistance Loading Test	No mechanical damage Inductance change to be within ±20% to the initial	85±2°C, 85%RH, Rated Current for 500±12 hours. Measure the test items after leaving at normal temperature and humidity for 24 hours.			
High Temperature Loading Test	No mechanical damage Inductance change to be within ±20% to the initial	85±2°C, Rated Current for 500±12 hours. Measure the test items after leaving at normal temperature and humidity for 24 hours.			
Reflow Test	No mechanical damage Inductance change to be within ±20% to the initial	Peak 260±5℃, 3 times			
Vibration Test	No mechanical damage Inductance change to be within ±20% to the initial.	Solder the sample on PCB. Vibrate as apply 10~55Hz, 1.5mm amplitude for 2 hours in each of three(X,Y,Z) axis (total 6 hours).			
	No mechanical damage	Bending Limit; 2mm Test Speed; 1.0mm/sec. Keep the test board at th PCB thickness : 1.6mm	e limit point in 5 sec.		
Bending Test	20 Unit :mm 10 R340 45 45 45				
	No indication of peeling shall occur on the terminal electrode.	W(kgf)	TIME(sec)		
Terminal Adhesion Test		0.5 10±1			
Drop Test	No mechanical damage Inductance change to be within ±20% to the initial.	Random Free Fall test on concrete plate. 1 meter, 10 drops			